

<b>Notice of References Cited</b>	Application/Control No. 10/057,427	Applicant(s)/Patent Under Reexamination KSENDZOV, ALEXANDER	
	Examiner Leith A Al-Nazer	Art Unit 2821	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0076149 A1	06-2002	Deacon, David A.G.	385/27
*	B	US-2004/0125833 A1	07-2004	Sarlet et al.	372/020
*	C	US-2002/0094150 A1	07-2002	Lim et al.	385/15
*	D	US-2004/0022474 A1	02-2004	Lim et al.	385/4
*	E	US-6,522,795 B1	02-2003	Jordan et al.	385/10
*	F	US-2004/0136412 A1	07-2004	Jones, Richard	372/020
*	G	US-2003/0219045 A1	11-2003	Orenstein et al.	372/20
*	H	US-6,009,115 A	12-1999	Ho, Seng-Tiong	372/92
*	I	US-5,004,342	04-1991	Bernard et al.	356/461
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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